

B/2133

**PATENT** 

#### IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of: Rajski et al.

**Application No.** 09/620,021

Filed: July 20, 2000 Confirmation No. 3823

For: CONTINUOUS APPLICATION AND

**DECOMPRESSION OF TEST PATTERNS** 

TO A CIRCUIT-UNDER-TEST

Examiner: Phung M. Chung

Art Unit: 2133

Attorney Reference No. 1011-54375-01

COMMISSIONER FOR PATENTS P.O. BOX 1450 ALEXANDRIA, VA 22313-1450

### **CERTIFICATE OF MAILING**

I hereby certify that this paper and the documents referred to as being attached or enclosed herewith are being deposited with the United States Postal Service as First Class Mail in an envelope addressed to: COMMISSIONER FOR PATENTS, P.O. BOX 1450, ALEXANDRIA, VA 22313-1450 on the date shown below.

Attorney or Agent for Applicants

Date Mailed June 24, 2005

# <u>PURSUANT TO 37 C.F.R. § 1.97(b)(4)</u>

Listed on the accompanying form PTO-1449 and enclosed herewith are several foreign language documents. Applicants respectfully request that these documents be listed as references cited on the issued patent.

Japanese Patent Publication No. 01-239486 recites an output response compressor.

Japanese Patent Publication No. 03-002579 recites a method and device for logic circuit test using compressed data. Japanese Patent Publication No. 05-215816 recites an information processing device. Japanese Patent Publication No. 11-030646 recites a semiconductor integrated circuit and test circuit to be comprised therein.

Copies of United States patents and United States published patent applications do not have to be provided to the Patent Office (37 C.F.R. 1.98(a)(2)(ii)). Copies of unpublished U.S. applications do not have to be provided, as long as the application is available on PAIR, as this

requirement of 37 C.F.R. § 1.98(a)(2)(iii) has been waived by the United States Patent and Trademark Office pursuant to the Official Gazette Notice on October 19, 2004 (1287 OG 163). Applicants will provide copies of such patents or applications upon request.

Applicants filed this Information Disclosure Statement ("IDS") before the mailing of a first Office action after the filing of a request for continued examination. As a result, no fee should be required to file this IDS. However, if the Patent Office determines that a fee is required for Applicants to file this IDS, please charge any such fees, or credit overpayment, to Deposit Account No. 02-4550. A duplicate copy of this IDS is enclosed.

The filing of this IDS shall not be construed to be an admission that the information cited in the statement is, or is considered to be, prior art or otherwise material to patentability as defined in 37 C.F.R. §1.56.

Respectfully submitted,

KLARQUIST SPARKMAN, LLP

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By

Patrick M. Bible

Registration No. 44,423

One World Trade Center, Suite 1600 121 S.W. Salmon Street

Portland, Oregon 97204

Telephone: (503) 226-7391

Facsimile: (503) 228-9446

cc: Client

**Docketing** 

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7	JUN 2 7 2005	
}	FORMATE	N DISCLOSURE STATEMENT
		BY APPLICANT

Attorney Docket Number	1011-54375-01
Application Number	09/620,021
Filing Date	July 20, 2000
First Named Inventor	Rajski
Art Unit	2133
Examiner Name	Phung M. Chung

### **U.S. PATENT DOCUMENTS**

Copies of U.S. Patent documents do not need to be provided, unless requested by the Patent and Trademark Office. For patents, provide the patent number and the issue date. For published U.S. applications, provide the publication number and the publication date. For unpublished pending patent applications, provide the application number and the filing date.

Examiner's Initials*	Cite No. (optional)	Number	Publication Date	Name of Applicant or Patentee

## FOREIGN PATENT DOCUMENTS

Examiner's Initials*	Cite No. (optional)	Country	Number	<b>Publication Date</b>	Name of Applicant or Patentee
		Japan	01-239486	9.25.1989	Masaaki
		Japan	03-002579	1.8.1991	Shuichi et al.
		Japan	05-215816	8.27.1993	Yasushi
		Japan	11-030646	2.2.1999	Hideki
Examiner's	Cite No.	No. OTHER DOCUMENTS			

Examiner's Initials*	Cite No. (optional)	OTHER DOCUMENTS

EXAMINER DATE  CONSTRUCTOR		
SIGNATURE: CONSIDERED:	EXAMINER SIGNATURE:	DATE CONSIDERED:

<sup>\*</sup> Examiner: Initial if reference considered, whether or not in conformance with MPEP 609. Draw line through cite if not in conformance and not considered. Include copy of this form with next communication to applicant.